

Search Notes

Application/Control No.

10/781,210

Examiner

TAN TRINH

Applicant(s)/Patent under
Reexamination

NAKANISHI, TOSHIKI

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	562.1	10/13/2006	TT
	561		
	575.7		
	121		
	127.3		
	132		
	424		
	140		
	82		
	73		
	517		
	63.4		
	67.16		
342	383		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	10/13/2006	TT
VO, NGUYEN	10/13/2006	TT